

<b>Search Notes</b>  <b>*1059315</b>  <b>0*</b>	<b>Application/Control No.</b>  10593150	<b>Applicant(s)/Patent Under Reexamination</b>  GUTMANN ET AL.
	<b>Examiner</b>  MAURICE MCDOWELL, JR	<b>Art Unit</b>  2628

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
East text search	7/7/10	MM
Inventor name search	7/7/10	MM
Foreign database search	7/7/10	MM
NPL search on IEEE and ACM databases "Fast Segmentation of Range images"	7/7/10	MM
Class/subclass combined with text search	7/7/10	MM
East text search	12/20/10	MM
Class/subclass combined with text	12/20/10	MM

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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